



DMN6075S

60V N-CHANNEL ENHANCEMENT MODE MOSFET

Summary

BV _{DSS}	R _{DS(ON)} Max	I _D Max T _A = +25°C
60V	$85m\Omega @ V_{GS} = 10V$	2.5A
607	120mΩ @ $V_{GS} = 4.5V$	2.0A

Description

This new generation MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions
- Backlighting

Features and Benefits

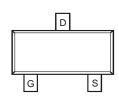
- N MOSFET
- Low On-Resistance
- Low Input Capacitance
- · Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

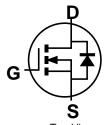
- Case: SOT23
- Case Material: Molded Plastic, "Green" Molding Compound;
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram Below
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 3
- Weight: 0.008 grams (Approximate)







Top View



Top View Pin Configuration

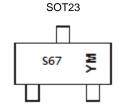
Ordering Information (Note 4)

Product	Reel Size (inches)	Tape Width (mm)	Quantity per Reel
DMN6075S-7	7	8	3,000
DMN6075S-13	13	8	10,000

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



S67 = Product Type Marking Code YM = Date Code Marking Y or \overline{Y} = Year (ex: E = 2017) M = Month (ex: 9 = September)

Date Code Key

Year	2014		~	2017	2018	2019	2020	202	1 20	22 2	2023	2024	2025
Code	В		~	E	F	G	Н	I		l	K	L	М
Month	n ,	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code		1	2	વ	Λ	5	6	7	8	a	0	N	ח



Maximum Ratings ($@T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Drain-Source Voltage		V_{DSS}	60	V	
Gate-Source Voltage			V_{GSS}	±20	V
Continuous Drain Current (Note 5) V _{GS} = 10V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I _D	2.0 1.5	А
Continuous Drain Current (Note 6) V _{GS} = 10V	ID	2.5 2.0	А		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%	5)	I _{DM}	12	А	

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Total Davier Discipation (Note 5)	T _A = +25°C	Б	0.8	W	
Total Power Dissipation (Note 5)	$T_A = +70^{\circ}C$	P_D	0.5		
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{ heta JA}$	157	°C/W	
Total Davier Discipation (Note C)	T _A = +25°C	D	1.15	W	
Total Power Dissipation (Note 6)	T _A = +70°C	P_D	0.7	VV	
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{ heta JA}$	110	°C/W	
Operating and Storage Temperature Range		$T_{J_i}T_{STG}$	-55 to +150	°C	

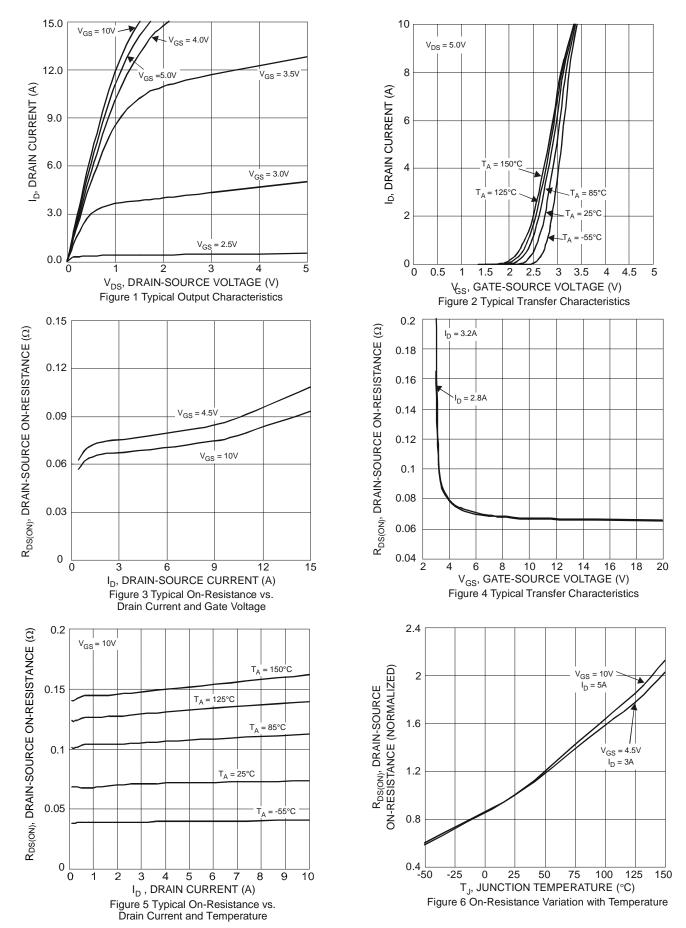
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)			•	•		
Drain-Source Breakdown Voltage	BV _{DSS}	60	_	_	٧	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	1	_	1.0	μΑ	$V_{DS} = 60V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	1	_	±100	nA	$V_{GS} = \pm 16V$, $V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(TH)}	1	_	3	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
Static Drain-Source On-Resistance	Dagger		69	85	mΩ	$V_{GS} = 10V, I_D = 3.2A$
Static Dialif-Source Off-Nesistance	R _{DS(ON)}		75	120	11152	$V_{GS} = 4.5V, I_D = 2.8A$
Diode Forward Voltage	V_{SD}	1	_	1.2	٧	$V_{GS} = 0V, I_{S} = 2.5A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C_{iss}		606	_	pF	,, ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,
Output Capacitance	Coss	1	32.6	_	pF	$V_{DS} = 20V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	1	24.6	_	pF	1 = 1.01/11/2
Gate Resistance	Rg	1	1.5	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = 10V)	Q_g	1	12.3	_	nC	
Total Gate Charge (V _{GS} = 4.5V)	Q_g	1	5.6	_	nC	$V_{DS} = 30V, I_D = 3A$
Gate-Source Charge	Q_{gs}	1	1.7	_	nC	$V_{DS} = 30V$, $I_D = 3A$
Gate-Drain Charge	Q_{gd}		1.9	_	nC	
Turn-On Delay Time	t _{D(ON)}	1	3.5	_	ns	
Turn-On Rise Time	t _R	1	4.1	_	ns	$V_{GS} = 10V, V_{DS} = 30V,$
Turn-Off Delay Time	t _{D(OFF)}		35	_	ns	$R_g = 20\Omega$, $R_L = 50\Omega$
Turn-Off Fall Time	t _F	_	11	_	ns	

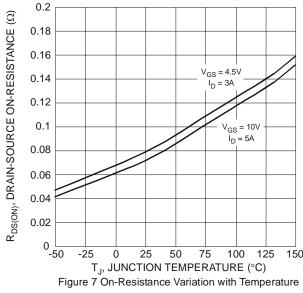
Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1-inch square copper plate.
 Short duration pulse test used to minimize self-heating effect.

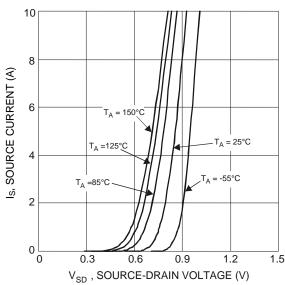
^{8.} Guaranteed by design. Not subject to product testing.

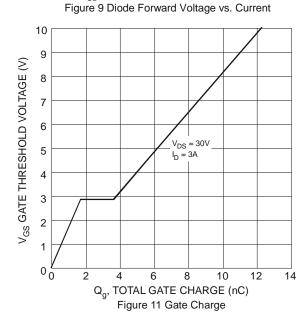












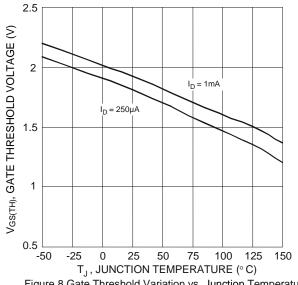
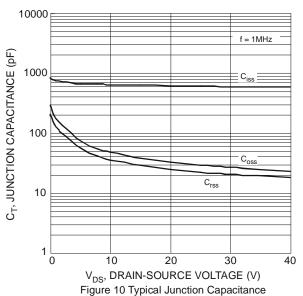


Figure 8 Gate Threshold Variation vs. Junction Temperature



100 R_{DS(ON)} Limited 10 ID, DRAIN CURRENT (A) 0.1 0.01 $T_A = 25^{\circ}C$ V_{GS} = 10V Single Pulse 0.001 DUT on 1 * MRP Board 100 $V_{\rm DS}$, DRAIN-SOURCE VOLTAGE (V)

Figure 12 SOA, Safe Operation Area



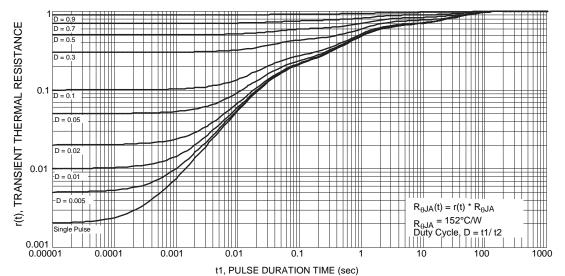
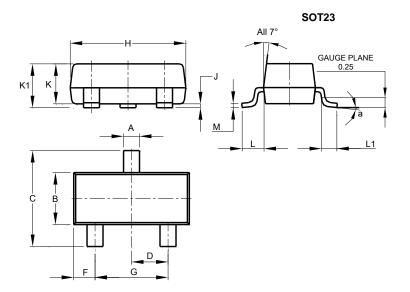


Figure 13 Transient Thermal Resistance



Package Outline Dimensions

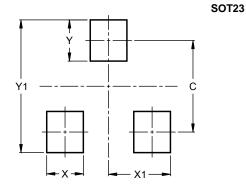
Please see http://www.diodes.com/package-outlines.html for the latest version.



SOT23							
Dim	Min	Max	Тур				
Α	0.37	0.51	0.40				
В	1.20	1.40	1.30				
С	2.30	2.50	2.40				
D	0.89	1.03	0.915				
F	0.45	0.60	0.535				
G	1.78	2.05	1.83				
Η	2.80	3.00	2.90				
7	0.013	0.10	0.05				
K	0.890	1.00	0.975				
K1	0.903	1.10	1.025				
L	0.45	0.61	0.55				
L1	0.25	0.55	0.40				
М	0.085	0.150	0.110				
а							
All Dimensions in mm							

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)
С	2.0
Х	0.8
X1	1.35
Y	0.9
Y1	2.9

March 2017

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